Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination CONNOR ET AL. | Examiner | Art Unit | Linda Krisciunas | 3623 | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-			
	В	US-			
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Ξ	US-			
	_	US-			
	J	U\$-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	P					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
	U	"Project Risk Assessment using the Analytic Hierarchy Process" by Mustafa et al, IEEE, 1991.		
	>	"Risk factors in enterprise wide information management systems projects" by Sumner, Proceedings of the 2000 ACM SIGCPR Conference on Computer Personnel research, 2000.		
	w	"Risk Management in Information Systems: Problems and Potential" by Smith et al, Communications of the Association for Information Systems, August 2001.		
	×			

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.